

<b>Search Notes</b>				<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
				09/973,773	YUN, HWA YOUNG
				Examiner	Art Unit
				Chris Parry	2623

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
725	48-49	10/27/2005	CLP
725	22	10/28/2005	CLP
725	135	10/28/2005	CLP
725	85	10/28/2005	CLP
725	87	10/27/2005	CLP
UPDATED	ABOVE	5/5/2006	CLP
<i>Updated search above</i>			
		10/04/06	KB
<i>Updated search above</i>			
		05/10/07	PCB

<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
	<b>DATE</b>	<b>EXMR</b>
See attached search strategy from EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB).	11/1/2005	CLP
Consulted Scott Beliveau on areas of search in class 725.	10/27/2005	CLP
See attached search strategy from EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB).	5/5/2006	CLP
<i>Updated search above</i>	10/04/06	KB
<i>Updated search above</i>	05/10/07	KB

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>